Power MOSFET

-20 V, -3.16 A, Single P-Channel TSOP-6

Features

- Ultra Low R_{DS(on)} to Improve Conduction Loss
- Low Gate Charge to Improve Switching Losses
- TSOP-6 Surface Mount Package
- This is a Pb-Free Device

Applications

- High Side Switch in DC-DC Converters
- Battery Management

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

| Paran | Symbol | Value | Unit | | |
|---|--|-----------------------|----------------|-------|-----------|
| Drain-to-Source Voltag | V_{DSS} | -20 | V | | |
| Gate-to-Source Voltage | Gate-to-Source Voltage | | | ±12 | V |
| Continuous Drain | Steady | T _A = 25°C | I _D | -2.5 | Α |
| Current (Note 1) | State | T _A = 85°C | 1 | -1.8 | |
| | t = 10 s | T _A = 25°C | 1 | -3.16 | |
| Power Dissipation (Note 1) | | | P _D | 0.98 | W |
| | t = 10 s | | | 1.60 | eet4U.com |
| Continuous Drain | Steady State | T _A = 25°C | I _D | -1.8 | Α |
| Current (Note 2) | | T _A = 85°C | | -1.3 | |
| Power Dissipation (Note 2) | T _A = 25°C | | P _D | 0.51 | W |
| Pulsed Drain Current | ulsed Drain Current t _p = 10 μs | | | -13 | Α |
| Operating Junction and | T _J , T _{STG} | –55 to 150 | °C | | |
| Source Current (Body D | I _S | -1.5 | Α | | |
| Lead Temperature for S (1/8" from case for 10 s | TL | 260 | °C | | |

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0751 in sq)

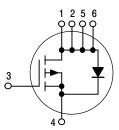


ON Semiconductor®

http://onsemi.com

| V _{(BR)DSS} | R _{DS(ON)} TYP | I _D MAX |
|----------------------|-------------------------|--------------------|
| | 91 mΩ @ 4.5 V | |
| –20 V | 144 mΩ @ 2.7 V | –3.16 A |
| | 188 mΩ @ 2.5 V | |

P-Channel



MARKING DIAGRAM



TSOP-6 CASE 318G STYLE 1

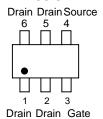


PT = Device Code M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

PIN ASSIGNMENT



ORDERING INFORMATION

| Device | Package | Shipping [†] |
|--------------|---------------------|-----------------------|
| NTGS3441PT1G | TSOP-6 (Pb-Free) | 3000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|----------------|-------|------|
| Junction-to-Ambient - Steady State (Note 3) | $R_{	heta JA}$ | 128 | °C/W |
| Junction-to-Ambient - t = 10 s (Note 3) | $R_{	heta JA}$ | 78 | |
| Junction-to-Ambient - Steady State (Note 4) | $R_{	hetaJA}$ | 244 | |

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
 Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = TBD in sq)

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| | 1 | | | | r | 1 | 1 |
|--|--------------------------------------|--|------------------------|-----|------|------|--------|
| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
| OFF CHARACTERISTICS | | | | | | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | | -20 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | | | | 16 | | mV/ °C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | T _J = 25°C | | | -1 | μΑ |
| | | $V_{GS} = 0 \text{ V}, V_{DS} = -20 \text{ V}$ | T _J = 125°C | | | -10 | 1 |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS}$ | s = ±12 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 5) | | | | | - | | • |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = –250 μA | 0.6 | | 1.6 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 3.2 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, I_{D} = -3.0 \text{ A}$ | | | 91 | 110 | mΩ |
| | | V _{GS} = 2.7 V, I _D | = -1.5 A | | 144 | 165 | |
| | | $V_{GS} = 2.5 \text{ V}, I_{D}$ | = -1.5 A | | 188 | | |
| Forward Transconductance | 9 _{FS} | $V_{DS} = -15 \text{ V}, I_{D} = -1.5 \text{ A}$ | | | 4.0 | | S |
| CHARGES, CAPACITANCES AND GATE RES | ISTANCE | • | | | | | |
| Input Capacitance | C _{ISS} | V _{GS} = 0 V, f = 1 MHz, V _{DS} = -15 V | | | 345 | | pF |
| Output Capacitance | C _{OSS} | | | | 150 | | 1 |
| Reverse Transfer Capacitance | C _{RSS} | | | | 40 | | 1 |
| Total Gate Charge | Q _{G(TOT)} | | | | 3.25 | 6.0 | nC |
| Threshold Gate Charge | Q _{G(TH)} | $V_{GS} = 4.5 \text{ V}, V_{DS} = -10 \text{ V}; I_D = -3.0 \text{ A}$ | | | 0.3 | | 1 |
| Gate-to-Source Charge | Q_{GS} | | | | 0.6 | | 1 |
| Gate-to-Drain Charge | Q_{GD} | | | | 1.4 | | 1 |
| SWITCHING CHARACTERISTICS (Note 6) | | | | | | | - |
| Turn-On Delay Time | t _{d(ON)} | $V_{GS} = 4.5 \text{ V}, V_{DD} = -10 \text{ V},$ $I_{D} = -1.5 \text{ A}, R_{G} = 4.7 \Omega$ | | | 7.0 | 12 | ns |
| Rise Time | T _r | | | | 14 | 25 | 1 |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 13 | 25 | 1 |
| Fall Time | T _f | | | | 4.0 | 8.0 | 1 |
| DRAIN-SOURCE DIODE CHARACTERISTICS | 3 | | | | | | |
| Forward Diode Voltage | V_{SD} | $V_{GS} = 0 V$ | T _J = 25°C | | 8.0 | 1.2 | V |
| | | $I_S = -3.0 \text{ A}$ | T _J = 125°C | | 0.7 | | |
| Reverse Recovery Time | t _{RR} | $V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = -3.0 \text{ A}$ | | | 25 | | ns |
| Charge Time | Ta | | | | 10 | | 1 |
| Discharge Time | T _b | | | | 15 | | 1 |
| Reverse Recovery Charge | Q_{RR} | | | | 15 | | nC |
| | | | | | | | |

^{5.} Switching characteristics are independent of operating junction temperatures

^{6.} Pulse Test: pulse width = 300 μ s, duty cycle = 2%

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

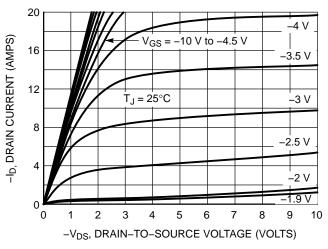


Figure 1. On-Region Characteristics

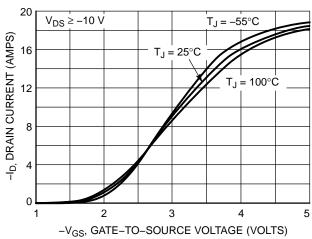


Figure 2. Transfer Characteristics

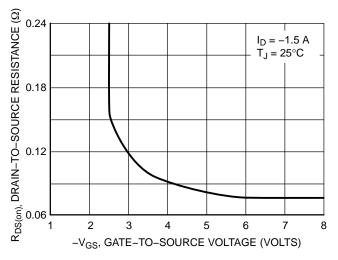


Figure 3. On-Resistance vs. Gate-to-Source Voltage

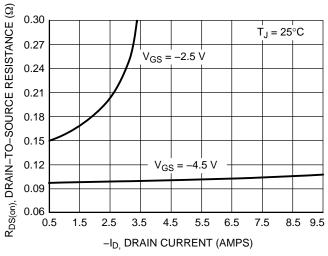


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

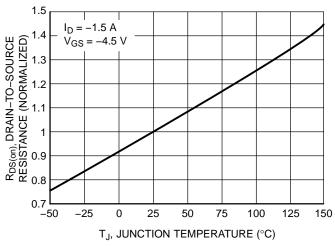


Figure 5. On–Resistance Variation with Temperature

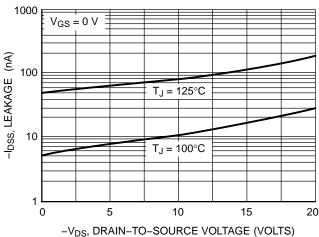


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

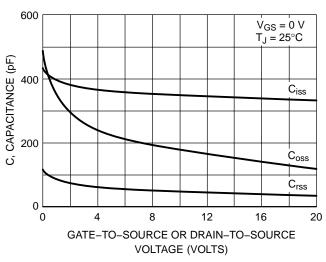


Figure 7. Capacitance Variation

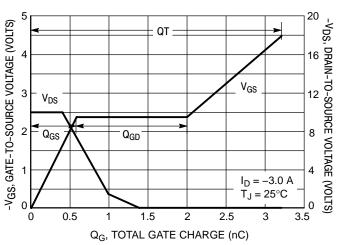


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

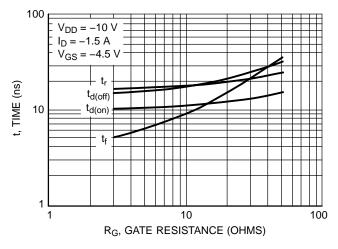


Figure 9. Gate Threshold Voltage Variation with Temperature

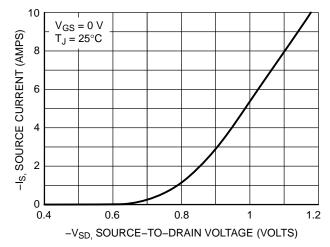
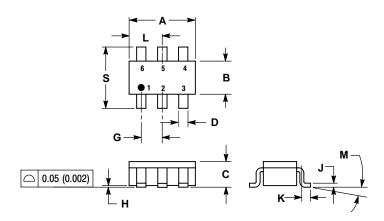


Figure 10. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

TSOP-6 CASE 318G-02 **ISSUE N**

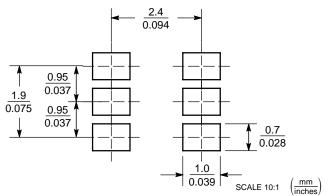


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
 4. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

| | | MILLIN | METERS | INCHES | | |
|----|---------|--------|--------|--------|--------|--|
| DI | DIM MIN | | MAX | MIN | MAX | |
| Α | | 2.90 | 3.10 | 0.1142 | 0.1220 | |
| В | | 1.30 | 1.70 | 0.0512 | 0.0669 | |
| С | | 0.90 | 1.10 | 0.0354 | 0.0433 | |
| D | | 0.25 | 0.50 | 0.0098 | 0.0197 | |
| G | | 0.85 | 1.05 | 0.0335 | 0.0413 | |
| Н | | 0.013 | 0.100 | 0.0005 | 0.0040 | |
| J | | 0.10 | 0.26 | 0.0040 | 0.0102 | |
| K | | 0.20 | 0.60 | 0.0079 | 0.0236 | |
| L | Ī | 1.25 | 1.55 | 0.0493 | 0.0610 | |
| M | | 0 ° | 10° | 0 ° | 10° | |
| S | | 2.50 | 3.00 | 0.0985 | 0.1181 | |

STYLE 1:
PIN 1. DRAIN
2. DRAIN
3. GATE
4. SOURCE
5. DRAIN
6. DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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